SHARP

To : LONGSE ELECTRONICS LIMITED

SPECIFICATIONS

Product Type   1/3-type Interline Color IS-CCD Area Sensor with 520k Pixels for NTSC

Model No.   R J 2 3 3 1 B A 0 P B

※   This specifications contains 21 pages including the cover and appendix.
If you have any objections, please contact us before issuing purchasing order.

CUSTOMERS ACCEPTANCE

DATE :

BY :

PRESENTED

BY : *J. Nakai*

J.NAKAI

Dept. General Manager

REVIEWED BY :   PREPARED BY :

J. Konishi   *T. Kenzaki*

Development Dept. II
Sensing Device Division
Electronic Components And Devices Group
SHARP CORPORATION

SHARP CORPORATION
SENSING DEVICE DIVISION DEV. DEPT. II
2012.11.30
MAIL DATE
ELECTRONIC COMPONENTS AND DEVICES GROUP

○ Handle this document carefully for it contains material protected by international copyright law. Any reproduction, full or in part, of this material is prohibited without the express written permission of the company.

○ When using the products covered herein, please observe the conditions written herein and the precautions outlined in the following paragraphs. In no event shall the company be liable for any damages resulting from failure to strictly adhere to these conditions and precautions.

    (1) Please do verify the validity of this part after assembling it in customer's products, when customer wants to make catalogue and instruction manual based on the specification sheet of this part.

    (2) The products covered herein are designed and manufactured for the following application areas. When using the products covered herein for the equipment listed in Paragraph（3）, even for the following application areas, be sure to observe the precautions given in Paragraph（3）. Never use the products for the equipment listed in Paragraph（4）.
    Office electronics
- Instrumentation and measuring equipment
- Machine tools
- Audiovisual equipment
- Home appliance
- Communication equipment other than for trunk lines

    (3) Those contemplating using the products covered herein for the following equipment which demands high reliability, should first contact a sales representative of the company and then accept responsibility for incorporating into the design fail-safe operation, redundancy, and other appropriate measures for ensuring reliability and safety of the equipment and the overall system.
- Control and safety devices for airplanes, trains, automobiles, and other transportation equipment
- Mainframe computers
- Traffic control systems
- Gas leak detectors and automatic cutoff devices
- Rescue and security equipment
- Other safety devices and safety equipment, etc

    (4) Do not use the products covered herein for the following equipment which demands extremely high performance in terms of functionality, reliability, or accuracy.
- Aerospace equipment
- Communications equipment for trunk lines
- Control equipment for the nuclear power industry
- Medical equipment related to life support, etc.

    (5) Please direct all queries and comments regarding the interpretation of the above three Paragraphs to a sales representative of the company.

○ Please direct all queries and regarding the products covered herein to a sales representative of the company.

SHARP

CONTENTS

1 DESCRIPTION

The RJ2331BA0PB is a 1/3-type(6.0mm) solid-state image sensor that consists of PN photo-diodes and CCDs(charge-coupled devices).

With approximately 520,000pixels (horizontal 1020 $\times$ vertical 507), the sensor provides a stable high-resolution color image.
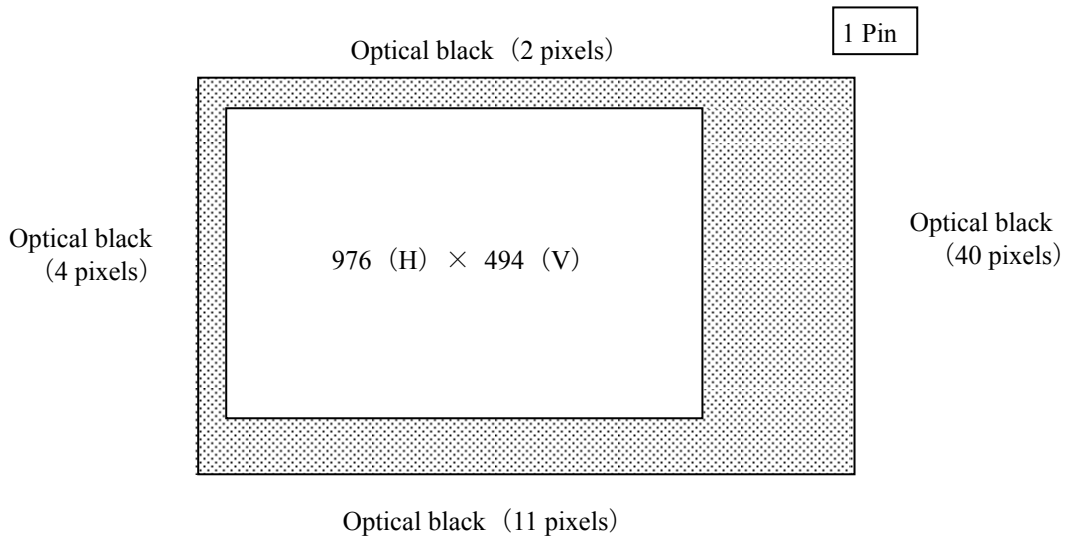
Features

1) Number of image pixels   : Horizontal 976$\times$vertical 494

   Pixel pitch   : Horizontal 5.0 μ m$\times$vertical 7.4 μ m

   Number of optical black pixels : Horizontal ; 4 front and 40 rear

                                    : Vertical   ; 11 front and 2 rear

2) Mg, G, Cy, and Ye Complementary color filters

3) Low fixed pattern noise and lag

4) No burn-in and no image lag distortion

5) Blooming suppression structure

6) Built-in output amplifier

7) 16-pin half-pitch DIP ［P-DIP016-0450］

   （Row space: 11.43mm）

8) Variable electronic shutter （1/60 to 1/100000 s）

9) N-type silicon substrate, N-MOS process,

10) Not designed or rated as radiation hardened

12) Built-in overflow drain voltage circuit, and reset gate voltage circuit

13) Horizontal shift register clock and reset gate clock voltage : 3.3V(Typ.)

Applications

1) Cameras(Camcorders, industrial monitor cameras, etc)

2) Pattern recognition

SHARP

2 ARRANGEMENT OF PIXELS AND COLOR FILTERS

Optical black （2 pixels）

1 Pin

Optical black
（4 pixels）

976 （H） × 494 （V）

Optical black
（40 pixels）

Optical black （11 pixels）

（1, 494）   （976, 494）

Cy	Ye	Cy	Ye	Cy
Mg	G	Mg	G	Mg
Cy	Ye	Cy	Ye	Cy
G	Mg	G	Mg	G
Cy	Ye	Cy	Ye	Cy
Mg	G	Mg	G	Mg

Ye	Cy	Ye	Cy	Ye
G	Mg	G	Mg	G
Ye	Cy	Ye	Cy	Ye
Mg	G	Mg	G	Mg
Ye	Cy	Ye	Cy	Ye
G	Mg	G	Mg	G

Cy	Ye	Cy	Ye	Cy
Mg	G	Mg	G	Mg
Cy	Ye	Cy	Ye	Cy
G	Mg	G	Mg	G
Cy	Ye	Cy	Ye	Cy
Mg	G	Mg	G	Mg

Ye	Cy	Ye	Cy	Ye
G	Mg	G	Mg	G
Ye	Cy	Ye	Cy	Ye
Mg	G	Mg	G	Mg
Ye	Cy	Ye	Cy	Ye
G	Mg	G	Mg	G

ODD
field

EVEN
field

（1, 1）   （976, 1）

3 PIN CONFIGURATION (TOP VIEW)

ϕ_{H2}	ϕ_{H1}	OOFD	ϕ_{RS}	PW	OFD	GND	OD
16	15	14	13	12	11	10	9

1	2	3	4	5	6	7	8
ϕ_{V4}	ϕ_{V3}	ϕ_{V2}	ϕ_{V1}	GND	NC$_1$	NC$_2$	OS
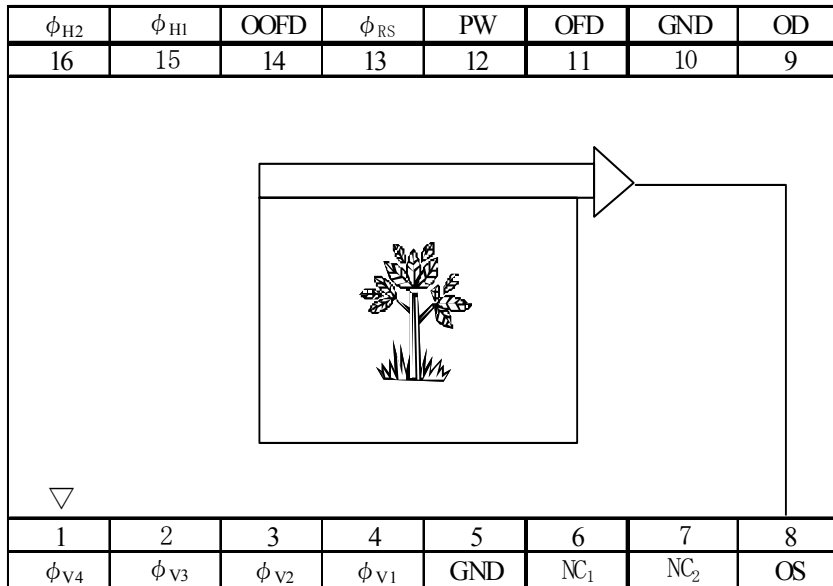
(TOP VIEW)

Symbol	Pin name
OD	Output transistor drain
OS	Output signals
ϕ_{RS}	Reset transistor clock
$\phi_{V1}, \phi_{V2}, \phi_{V3}, \phi_{V4}$	Vertical shift register clock
ϕ_{H1}, ϕ_{H2}	Horizontal shift register clock
OFD	Overflow drain
OOFD	Overflow drain output
PW	P-well
GND	Ground
NC$_1$,NC$_2$	No connection

4 ABSOLUTE MAXIMUM RATINGS

(Ta＝25℃)

Parameter	Symbol	Ratings	Unit
Output transistor drain voltage	V_{OD}	0 to＋18	V
Overflow drain voltage	V_{OFD}	0 to＋37	V
Overflow drain output	V_{OOFD}	Internal output(Note 1)	
Reset gate clock voltage	$V_{\phi RS}$	Internal output(Note 2)	
Vertical shift register clock voltage	$V_{\phi V}$	V_{PW} to ＋17.5	V
Horizontal shift register clock voltage	$V_{\phi H}$	－0.3 to ＋12	V
Voltage difference between P-well and vertical clock	V_{PW}-$V_{\phi V}$	－28.0 to 0	V
Voltage difference between vertical clocks	$V_{\phi V}$-$V_{\phi V}$	0 to ＋1 5(Note3)	V
Storage temperature	Tstg	－40 to ＋90	℃
Ambient operating temperature	Topr	－30 to ＋85	℃

(Note 1) Use the circuit parameter indicated in "8. STANDARD OPERATING CIRCUIT EXAMPLE" and
do not connect to DC voltage directly. When OOFD is connected to GND, connect V_{OD} to GND.

(Note 2) Do not connect to DC voltage directly. When φ$_{RS}$ is connected to GND, connect V_{OD} to GND.
Reset gate clock is applied below 8Vp-p.

(Note 3) When clock width is below 10μs, and clock duty factor is below 0.1%,voltage difference between
vertical clocks is will be below 27V.

5 RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Min	Typl	Max	Unit
Operating ambient temperature	T_{opr}		25.0		℃
Output transistor drain voltage	V_{OD}	14.55	15.0	15.45	V
Overflow drain clock p-p level（Note1）	$V_{\phi OFD}$	21.5		23.5	V
Ground	GND		0.0		V
P-well voltage （Note2）	V_{pw}	-9.0		$V\phi VL$	V
Vertical shift register clock LOW level	$V_{\phi V1L}, V_{\phi V2L}$ $V_{\phi V3L}, V_{\phi V4L}$	-8.5	-8.0	-7.5	V
Vertical shift register clock INTERMEDIATE level	$V_{\phi V1I}, V_{\phi V2I}$ $V_{\phi V3I}, V_{\phi V4I}$		0.0		V
Vertical shift register clock HIGH level	$V_{\phi V1H}$ $V_{\phi V3H}$	14.55	15.0	15.45	V
Horizontal shift register clock LOW level	$V_{\phi H1L}, V_{\phi H2L}$	-0.05	0.0	0.05	V
Horizontal shift register clock HIGH level	$V_{\phi H1H}, V_{\phi H2H}$	3.0	3.3	3.6	V
Reset gate clock p-p level（Note 1）	$V_{\phi RSH}$	3.0	3.3	3.6	V
Vertical shift register clock Frequency	$V_{\phi V1}, V_{\phi V2}$ $V_{\phi V3}, V_{\phi V4}$		15.73		kHz
Horizontal shift register clock frequency	$f_{\phi H1}, f_{\phi H2}$		18.0		MHz
Reset gate clock frequency	$f_{\phi RS}$		18.0		MHz

・Connect NC_1 to GND NC_2 to GND directly or through a capacitor larger then 0.047μ F

(Note1) Use the circuit parameter indicated in "8 EXAMPLE OF STANDARD OPERATING CIRCUIT "(P 11),
     and do not connect to DC voltage directly.
(Note2) V_{PW} is set below $V_{\phi VL}$ that is low level of vertical shift register clock, or is used with the same power
     supply that is connected to V_L of V driver IC.

・ To apply power, first connect GND and then turn on OD. After turning on V_{OD}, turn on V_{PW} first and then
   turn on other powers and pulses.
    Do not connect the device to or disconnect it from the plug socket white power is being applied.

6 CHARACTERISTICS

Ambient temperature : +25℃, but +60℃ for parameter No.4 and on 5.

Operating conditions : the typical values specified in "5 RECOMMENDED OPERATING CONDITION".

Color temperature of light source : 3200K ,IR cut-off filter (CM-500,1mmt) is used.

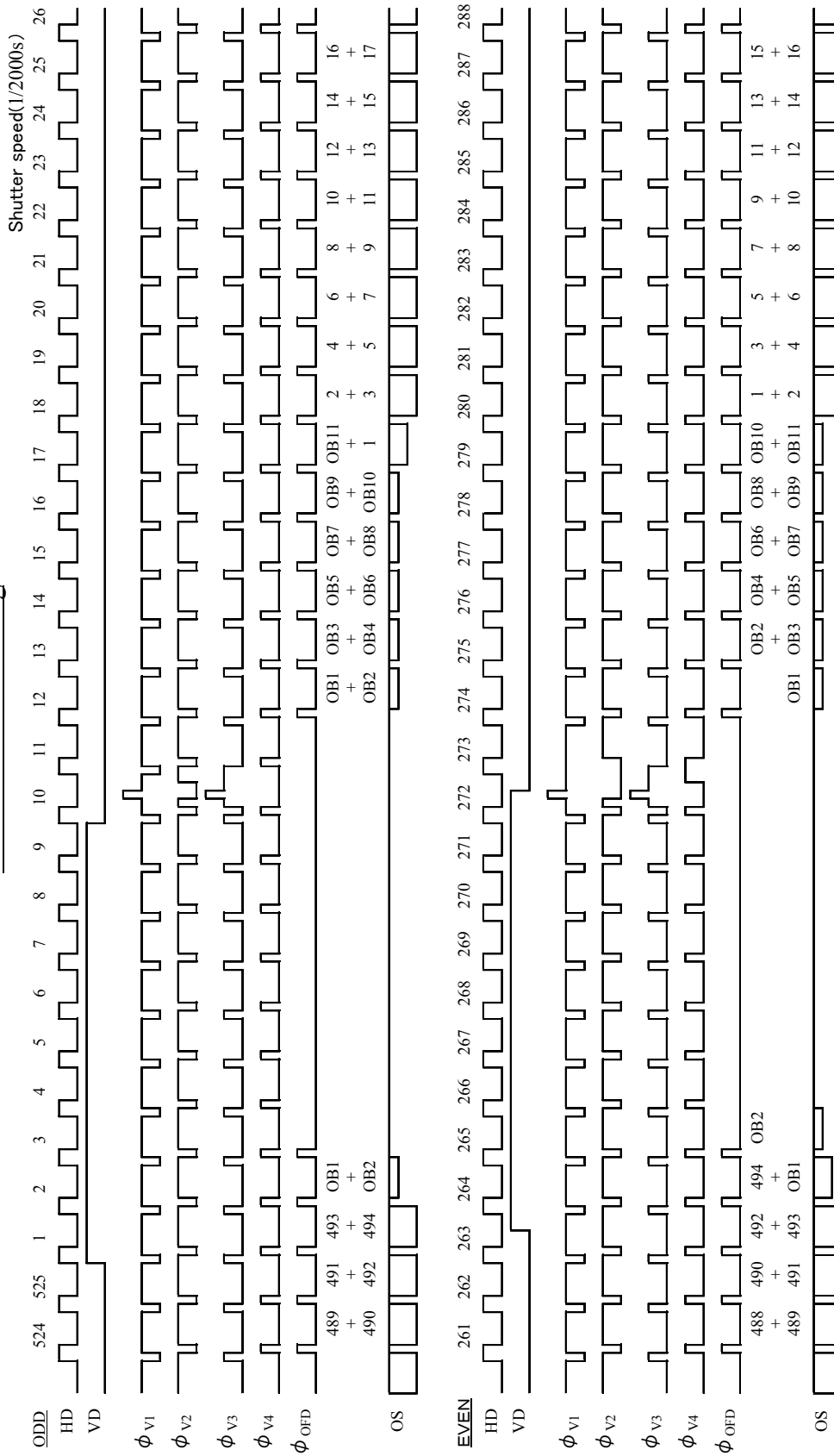| No.	Parameter	Symbol	Note	Minimum	Typical	Maximum	Unit
1	Standard output voltage	Vo	（1）		150		mV
2	Photo response non-uniformity	PRNU	（2）			10	%
3	Saturation output voltage	Vsat	（3）	1200			mV
4	Dark output voltage	Vdark	（4）		0.5	3.0	mV
5	Dark signal non-uniformity	DSNU	（5）		0.5	2.0	mV
6	Sensitivity	R	（6）	1900	2400		mV
7	Smear ratio	SMR	（7）		-125	-105	d B
8	Image lag	AI	（8）			1.0	%
9	Blooming suppression ratio	ABL	（9）	1000			
10	Current dissipation	I_{OD}			5.0	9.0	mA
11	Output impedance	Ro			200		Ω
12	Vector breakup		（10）			5.0	° ,%
13	Line crawling		（11）			1.5	%
14	Luminance flicker		（12）			2.0	%

Note :
  （1） The average output voltage of under the uniform illumination. The standard exposure condition is
        defined when Vo is 150 mV.
  （2） The image area is divided into 10×10 segments under the standard exposure condition.
        The voltage of a segment is the average output voltage of all pixels within the segment.
        PRNU is defined by (Vmax – Vmin) / Vo, where Vmax and Vmin are the maximum and minimum
        values of each segment's voltage respectively.
  （3） The image area is divided into 10×10 segments. The segment's voltage is the average Output voltages
        of all pixels within the segment. Vsat is the minimum segment's voltage under 15 times exposure
        of the standard exposure condition.
  （4） The average output voltage under the non-exposure condition.
  （5） The image area is divided into 10×10 segments under the non-exposure condition.
        DSNU is defined by (Vdmax – Vdmin), where Vdmax and Vdmin are the maximum and minimum
        values of each segment's voltage respectively.
  （6） The average output voltage when a 1000 lux light source with a 90% reflector is imaged by
        a lens of F4, f50 mm.
  （7） The sensor is exposed only in the central area of V/10 square with a lens at F4, where V is the vertical image
        size. SMR is defined by the ratio of the output voltage detected during the vertical blanking period
        to the maximum of the output voltage in the V/10 square.
  （8） The sensor is exposed at the exposure level corresponding to the standard condition.
        AI is defined by the ratio between the output voltage measured at the 1st field during the non-exposure
        period and the standard output voltage.
  （9） The sensor is exposed only in the central area of V/10 square, where V is the vertical image size.
        ABL is the ratio between the exposure at the standard condition and the exposure at a point where
        a blooming is observed.
  （10） Observe with a vector scope when the color bar chart is imaged under the standard exposure condition.
  （11） The difference between the average output voltage of the (Mg+Ye),(G+Cy) lime and
        the (Mg + Cy),(G + Ye) line under the standard exposure condition.
  （12） The difference between the average output voltage of the odd field and the even field
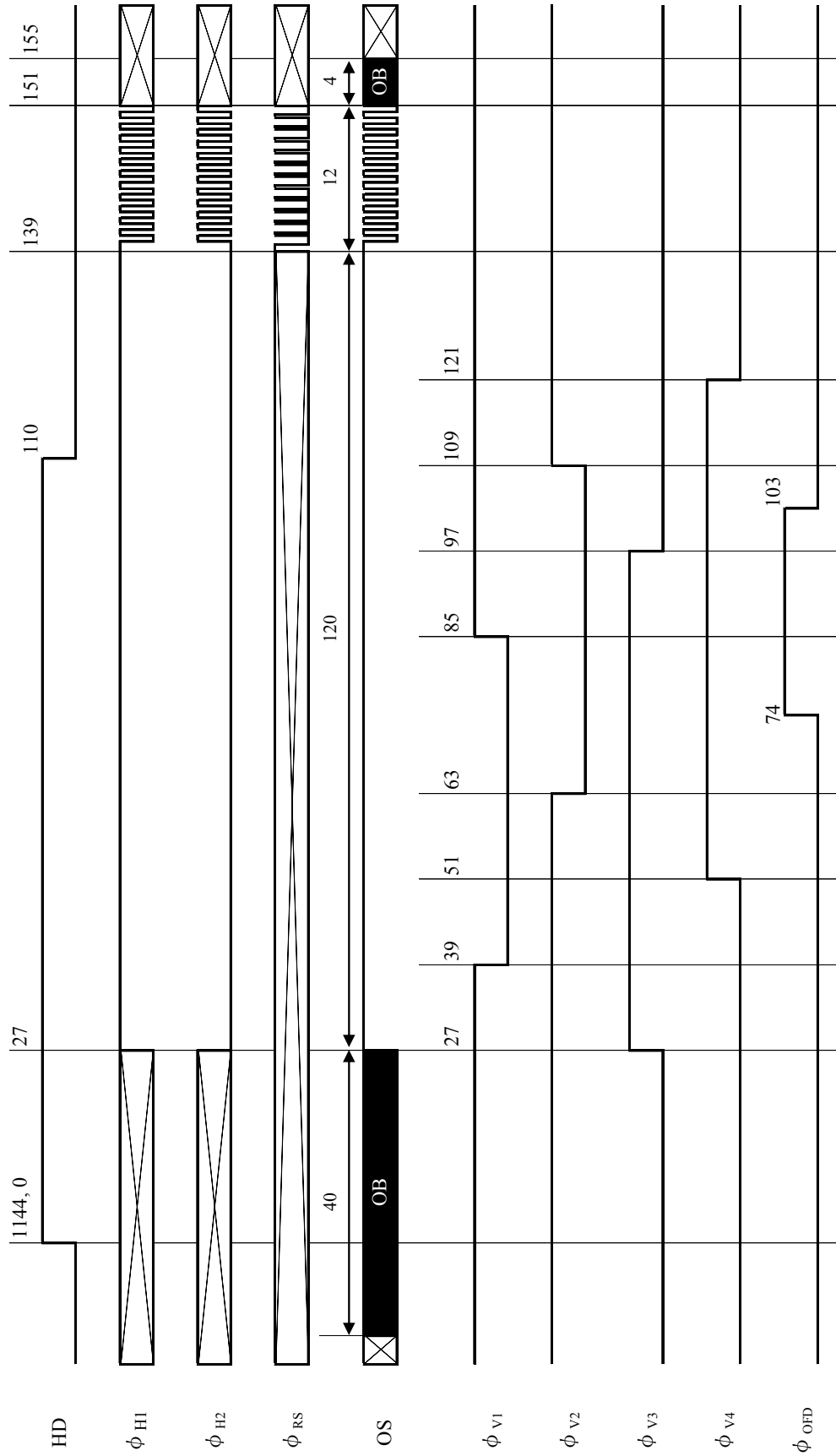
  V_{OFD} of the internal output satisfies with ABL then 1000 times exposure of the standard exposure condition,
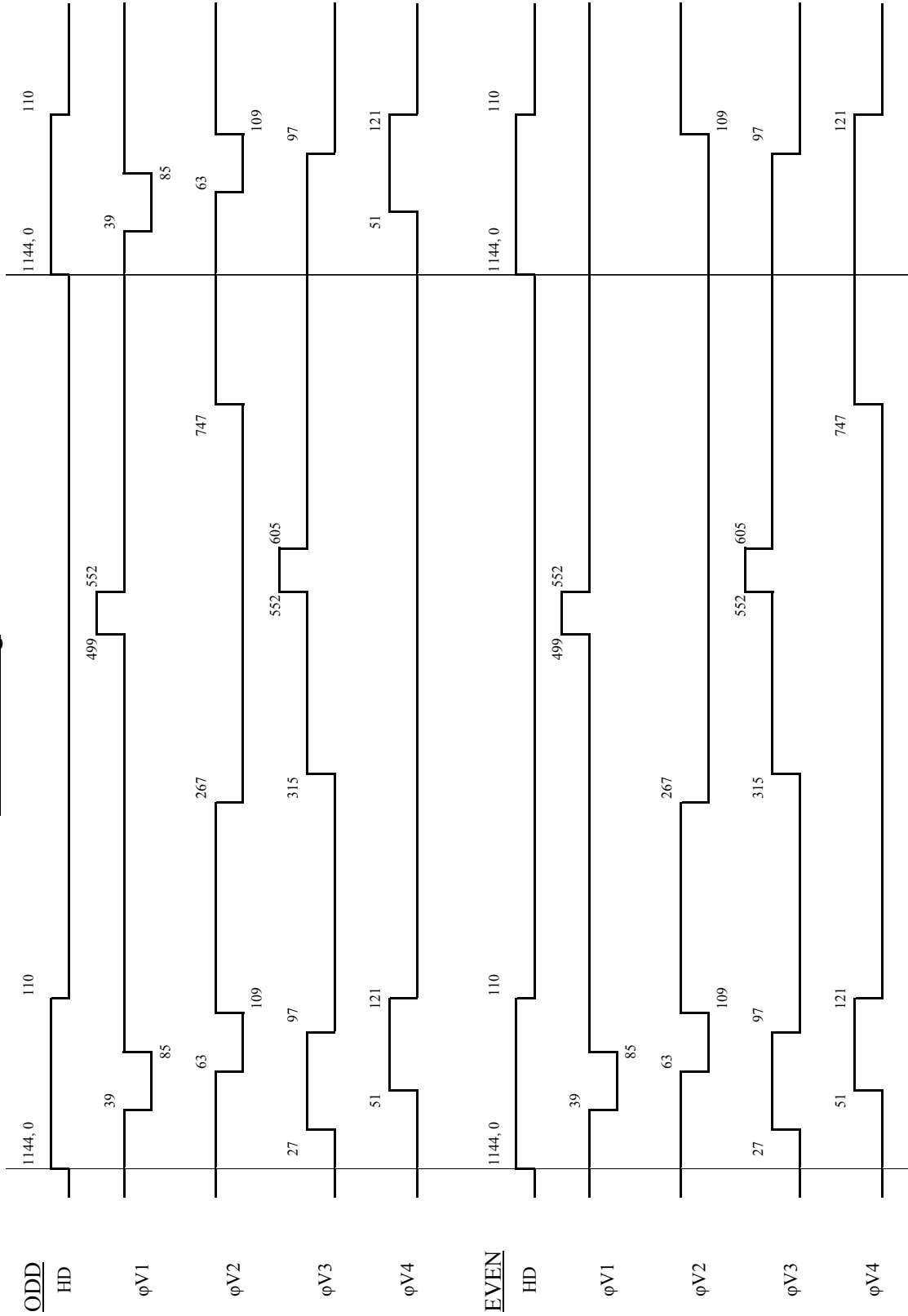and Vsat larger than 1200mV

7 DRIVE TIMING CHART EXAMPLE

Vertical transfer timing

Shutter speed(1/2000s)

ODD

| HD |
| VD |
| φV1 |
| φV2 |
| φV3 |
| φV4 |
| φOFD |
| OS |

524 525 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26

489 491 493 OB1 OB1 OB3 OB5 OB7 OB9 OB11 2 4 6 8 10 12 14 16
 +   +   +   +   +   +   +   +   +   +   + + + + +   +   +   +
490 492 494 OB2 OB2 OB4 OB6 OB8 OB10 1 3 5 7 9 11 13 15 17

EVEN

| HD |
| VD |
| φV1 |
| φV2 |
| φV3 |
| φV4 |
| φOFD |
| OS |

261 262 263 264 265 266 267 268 269 270 271 272 273 274 275 276 277 278 279 280 281 282 283 284 285 286 287 288

488 490 492 494 OB2 OB2 OB4 OB6 OB8 OB10 1 3 5 7 9 11 13 15
 +   +   +   +   +   +   +   +   +   +   + + + + + +   +   +
489 491 493 OB1 OB1 OB3 OB5 OB7 OB9 OB11 2 4 6 8 10 12 14 16

Horizontal transfer timing

	1144, 0	27	110	139	151 155
HD					
ϕ_{H1}					
ϕ_{H2}					
ϕ_{RS}		120			
OS	40 OB	27		12	4 OB
ϕ_{V1}		27 39 51 63 85 97 109 121			
ϕ_{V2}					
ϕ_{V3}		103			
ϕ_{V4}		74			
ϕ_{OFD}					

Readout timing

ODD

HD 1144, 0   110   39   85   63   109   97   27   121   51   499   552   267   315   552   605   747   1144, 0   110   39   85   63   109   97   51   121

φV1

φV2

φV3

φV4

EVEN

HD 1144, 0   110   39   85   63   109   97   27   121   51   499   552   267   315   552   605   747   1144, 0   110   109   97   121   51   747

φV1

φV2

φV3

φV4

8 EXAMPLE STANDARD OPERATING CIRCUIT
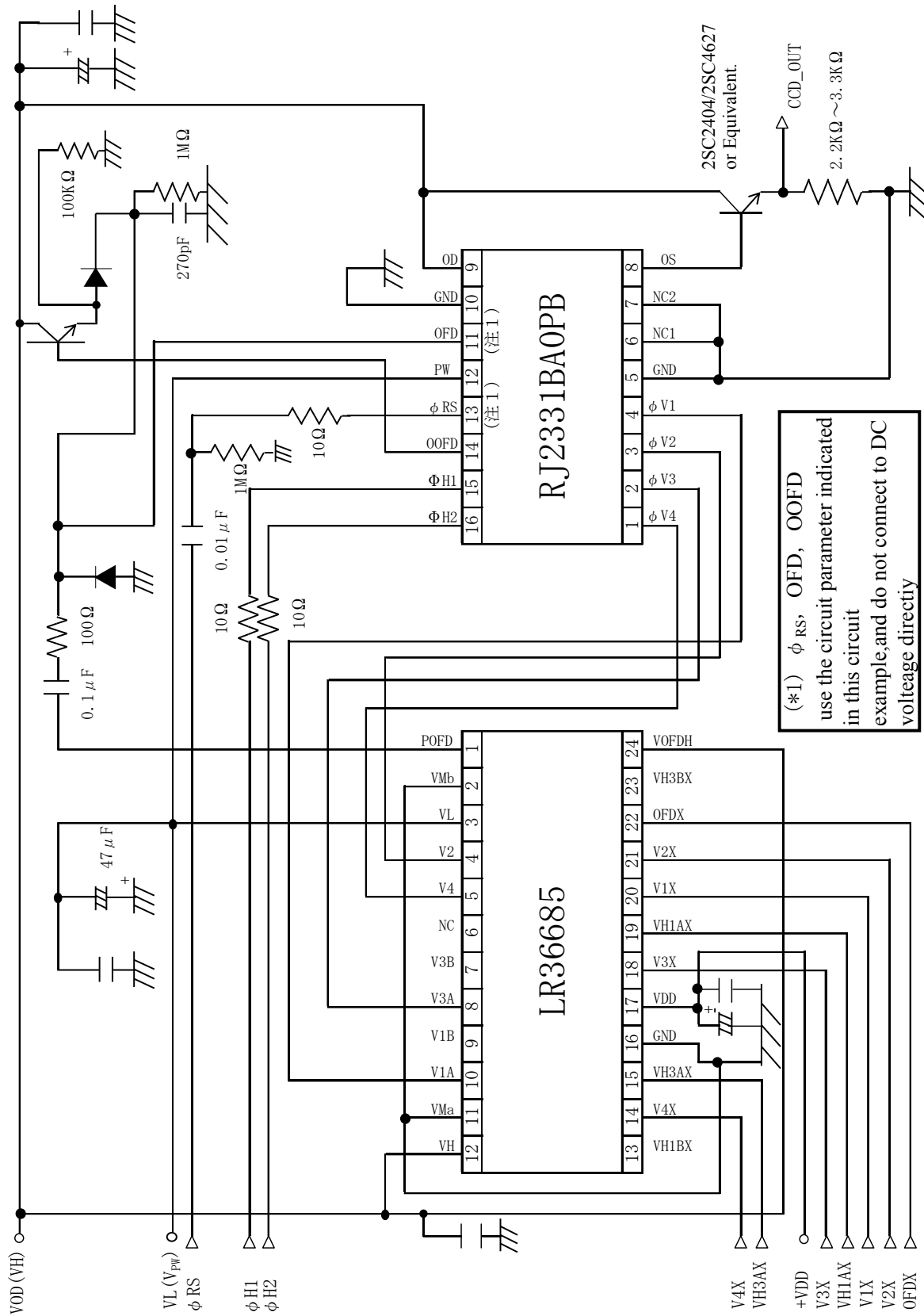
(*1) ϕ_{RS}, OFD, OOFD use the circuit parameter indicated in this circuit example,and do not connect to DC volteage directiy

9 SPECIFICATIONS FOR BLEMISH

1 Definition of blemish

	Level of blemish (mV)		Permitted number of blemish		Comment
White blemish (Exposed)	$23 \leqq B$		0		・See fig.9-1(a)、fig.9-2
	$13 \leqq B < 23$		M		・$Vout = Vstd$
	$B < 13$		no count		・$M + N = 10$
Black blemish (Exposed)	$23 \leqq B$		0		Up to 4 blemishes are
	$13 \leqq B < 23$		N		Allowed in AREA 1
	$B < 13$		no count		
White blemish (Non_exposed)			AREA I	AREA II	・See fig.9-1(b)、fig.9-2
	$12 < B$		0	0	・Sum of the blemishes in
	$9 < B \leqq 12$		1	3	AREA I and AREA II
	$7 < B \leqq 9$		2	4	Are allowed up to 6.
	$6 < B \leqq 7$		4	5	
	$B \leqq 6$		no count		
White blemish (Shutter mode)	$4.5 \leqq B$		0		・See fig.9-1(a)
	$B < 4.5$		no count		・$Vou = Vstd/10$
Black blemish (Shutter mode)	$4.5 \leqq B$		0		・The electronic shutter
	$B < 4.5$		no count		Speed is set at 1/10000s

《Note》

- B : Blemish level defined in fig.9-1
- Vout : Average output voltage
- Vstd : 150 mV. The standard output voltage defined in the specification of the characteristics.

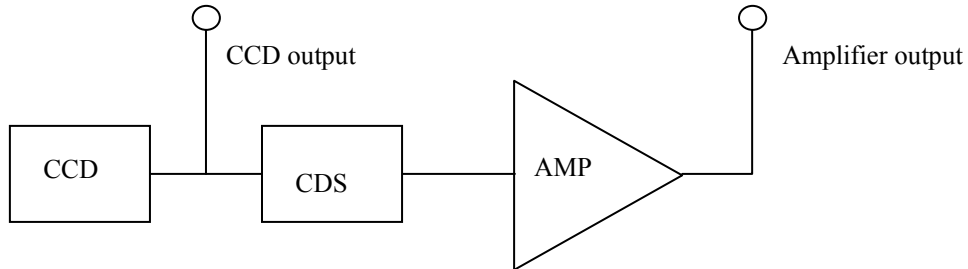## 2）Definition of stain

The measuring area is divided into segments which include 20×20 pixels, respectively.

The difference between the average output voltage of neighboring segments is permitted below 1.5 mV, under the condition that the average outputvoltage of all imaging pixels is 75 mV (= Vstd/2)

【MEASURING CONDITION】

・Ta : 60℃
・Measuring block diagram

CCD output   Amplifier output

| CCD | | CDS | | AMP |

The output voltage is measured at the CCD output.
The gain of the amplifier is adjusted to the unity between the CCD output and the amplifier output.
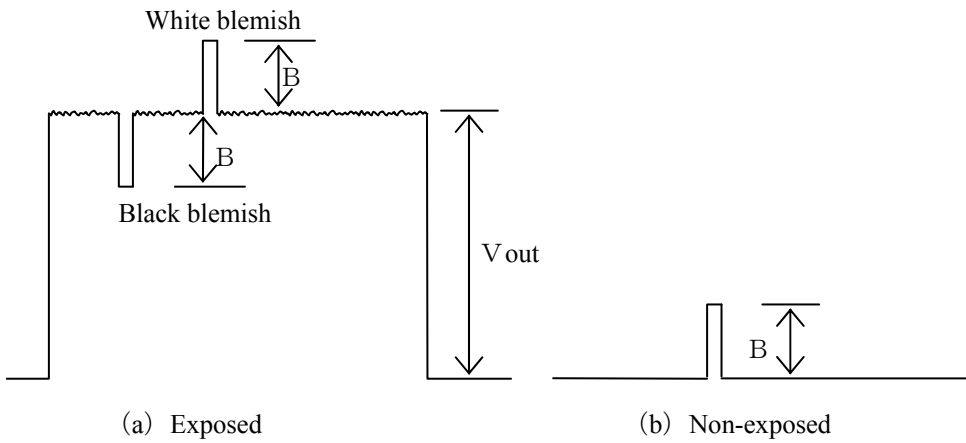
White blemish

B

B

Black blemish

V out

B

（a）Exposed   （b）Non-exposed

fig.　9-1　Definition of blemish level
(The wave form is the luminance signal measured at the Amplifier output.)

【MEASURING AREA】
Measuring area includes all pixels in the image and the optical black area excluding the outer 10 pixels of the left
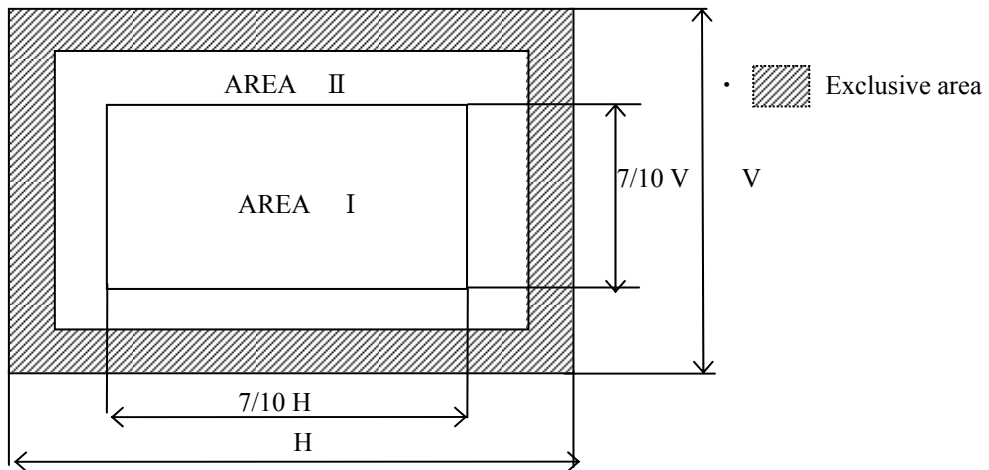and right sides and the outer 9 lines of the upper and lower sides in the image area.

AREA Ⅱ

AREA Ⅰ

・ Exclusive area

7/10 V   V

7/10 H

H

fig.　9-2　Definition of the measuring area

10 PRECAUTIONS

10.1. Package breakage

In order to prevent the package from being broken, observe the following instructions:

1） The CCD is a precise optical component and the package material is plastic. Therefore,
　・Take care not to drop the device when mounting, handling, or transporting.
　・Avoid giving a shock to the package. Especially when leads are fixed to the socket and the circuit board, small shock could break the package more easily than when the package isn't fixed.

2） When mounting the package on the housing, be sure that the package is not bent. If a bent package is forced into place between a hard plate or the like, the package may be broken.

3） If any damage or breakage occur on the surface of the glass cap, its characteristics could deteriorate.
Therefore,
　・Do not hit the glass cap.
　・Do not give a shock large enough to cause distortion.
　・Do not scrub or scratch the glass surface.
Even a soft cloth or applicator, if dry, could cause dust to scratch the glass.

10.2. Electrostatic damage

As compared with general MOS-LSI, CCD has lower ESD.
Therefore, please take the following anti-static measures when handling the CCD:

1） Always discharge static electricity by grounding the human body and the instrument to be used.
To ground the human body, provide resistance of about 1 Meg ohm between the human body and the ground to be on the safe side.

2） When directly handling the device with fingers, hold the part without leads and do not touch any lead.

3） To avoid generating static electricity,
a. do not scrub the glass surface with cloth or plastic
b. do not attach any tape or labels
c. do not clean the glass surface with dust-cleaning tape

4） When storing or transporting the device, put it in a container of conductive material.

SHARP

10.3. Dust and contamination

Dust or contamination on the glass surface could deteriorate the output
characteristic or cause a scar. In order to minimize dust or contamination on
the glass surface, take the following precautions:

1）   Handle CCD in a clean environment such as a cleaned booth.
      (The cleanliness level should be, if possible, class 1,000 at least.)

2）   Do not touch the glass surface with fingers. If dust or contamination gets
      on the glass surface, the following cleaning method is recommended:
      ・Dust from static electricity should be blown off with an ionized air blower.
      For anti-electrostatic measures, however, ground all the leads on the device
      before blowing off the dust.
      ・The contamination on the glass surface should be wiped off with a clean
      applicator soaked in Isopropyl alcohol. Wipe slowly and gently in one
      direction only.
      Frequently replace the applicator and do not use the same applicator to clean
      more than one device.

※ Note: In most cases, dust and contamination are unavoidable, even before the
          device is first used. It is, therefore, recommended that the above procedures
          should be taken to wipe out dust and contamination before using the device.

10.4. 0ther

1）   Soldering should be manually performed within 5 seconds at 350℃ maximum at
      soldering iron.

2）   Avoid using or storing the CCD at high temperature or high humidity as it is a precise optical
      component. Do not give a mechanical shock to the CCD.

3）   As color filters are used in CCD, must not be exposed to strong light environment such as UV and direct
      sun light for long periods during your use, storage, transportation and fabrication. If exposed to strong
      light environment for long periods, color filters will be discolored. When strong light is radiated to CCD,
      CCD image could be persisted even without bias.

4）   The color filters of this CCD are fabricated of pigment color filter materials which have better light
      resistance performance.   When it is used in surveillance camera, however, CCD image could be
      persisted if it captures light source for long periods even if it is indoor light (fluorescent lamp,
      incandescent lamp, etc.) or outdoor light (fluorescent lamp, mercury lamp, etc.).This phenomenon could
      happen at power-off when fixed iris lens is used.

5）   The color filters of this CCD are fabricated of pigment color filter materials which have better light
      resistance performance.   When it is used for capturing high luminance object by electronic iris
      exposure control system, however, object luminance may become excessive and it will possibly
      accelerate the discoloration of its color filter. In such a case, it is advisable that taking lens with the
      automatic iris and closing of the shutter during the power-off mode should be properly arranged. Prior to
      using this CCD continuously in a severe environment which exceeds normal conditions, consult our
      company.

6）   The exit pupil position of lens should be more than 25 mm from the top surface of the CCD.

7）   CCD has the possibility that white blemish, which originates in the structure of CCD with
      the passage of time by an external factor such as the radiations, could be generated.
      Please use white blemish compensation circuit for white blemish generated afterward.

11 PACKAGE OUTLINE AND PACKING SPECIFICATION

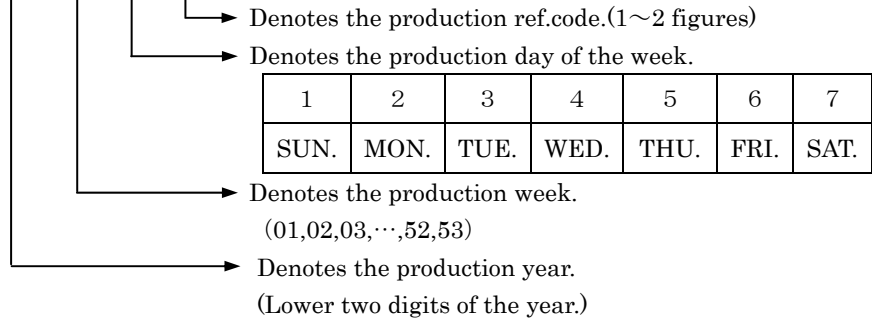### 11．1 Package Outline Specification

Refer to attached drawing.

（The seal resin stick out from the package shall be passed.　And,the seal resins are two kinds of colors,while and transparency.）

11．2 Markings

Marking contents

（1）．Product name　　：　RJ2331BA0PB
（2）．Company name　：　SHARP
（3）．Country of origin：　JAPAN
（4）．Date code　　　　：　YY WW X XX

Denotes the production ref.code.(1～2 figures)

Denotes the production day of the week.

1	2	3	4	5	6	7
SUN.	MON.	TUE.	WED.	THU.	FRI.	SAT.

Denotes the production week.
（01,02,03,···,52,53）

Denotes the production year.
（Lower two digits of the year.）

Positions of markings are shown in the package outline drawing.
But,markings shown in that drawing are not provided any measurements of their characters and their positions.

11．3 Packing Specification

3－1．Packing materials

Material Name	Material Spec.	Purpose
Device case	Cardboard(300devices/case)	Device tray fixing
Device tray	Conductive plastic (50devices/tray)	Device packing(6trays/case)
Cover tray	Conductive plastic(1tray/case)	Device packing
PP band	Polypropylene	Device tray fixing
Buffer	Cardboard(2sheets/case)	Shock absorber of device tray
Plastic film bag	Plastic film	Device tray fixing
Tape	Paper	Sealing plastic film bag and device case
Label	Paper	Indicates part number,quantity and date of manufacture

3－2．External appearance of packing
Refer to attached drawing

11．4 Precaution

1）．Before unpacking, confirm the imports of the chapter "Handling Precaution" in this device specification.
2）．Unpacking should be done on the stand treated with anti-ESD.　At that time, the same anti-ESD treatment should be done to operator's body, too.

ISSUE NUMBER	(NOTE)
27122ADC	

11. 5 Chemical substance information in the product

Product Information Notification based on Chinese law, Management Methods for Controlling Pollution by Electronic Information Products.

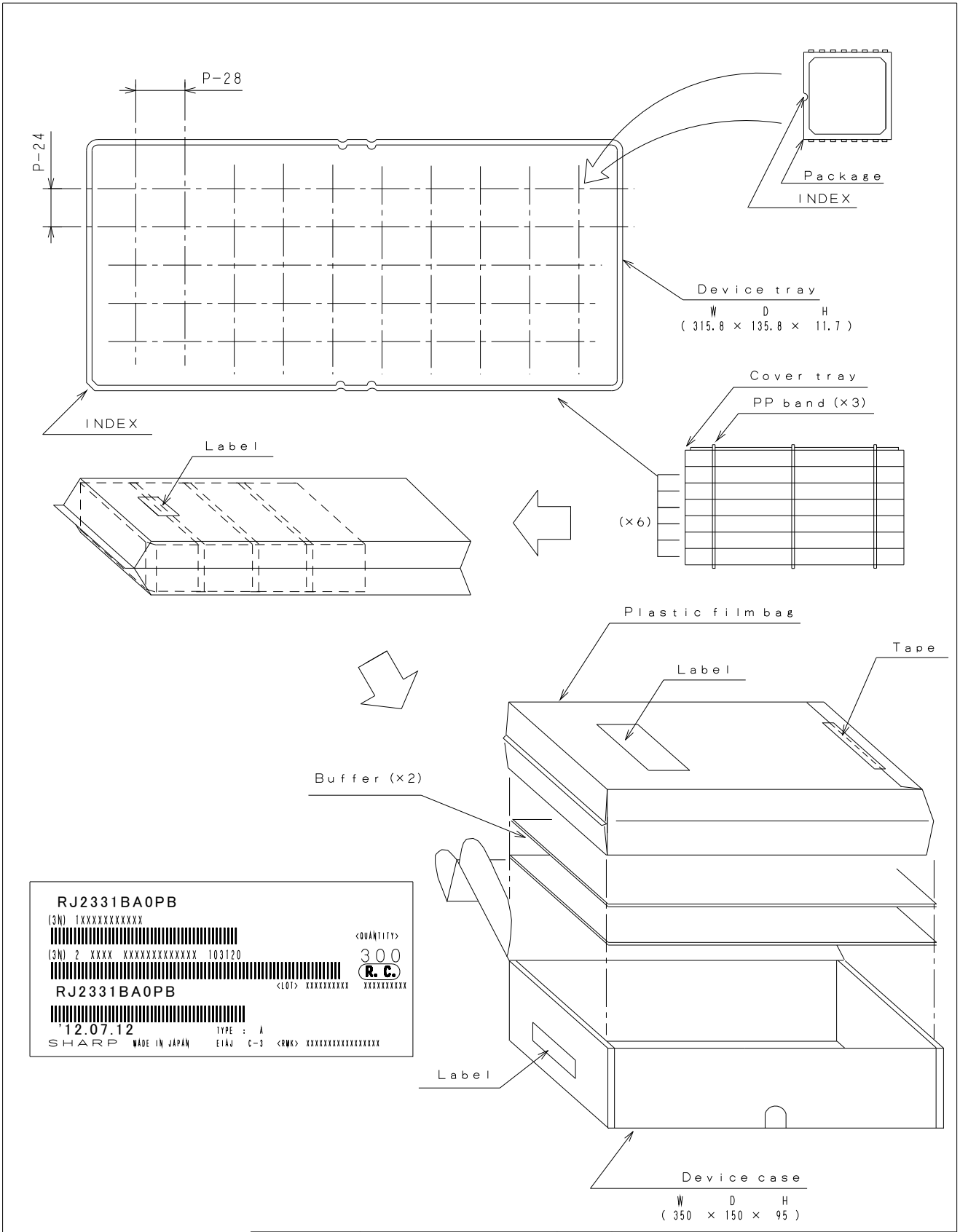Names and Contents of the Toxic and Hazardous Substances or Elements in the Product

Lead (Pb)	Mercury (Hg)	Cadmium (Cd)	Hexavalent Chromium (Cr(VI))	Polybrominated Biphenyls (PBB)	Polybrominated Diphenyl Ethers (PBDE)
○	○	○	○	○	○

○ : indicates that the content of the toxic and hazardous substance in all the homogeneous materials of the part is below the concentration limit requirement as described in SJ/T 11363-2006.

× : indicates that the content of the toxic and hazardous substance in at least one homogeneous material of the part exceeds the concentration limit requirement as described in SJ/T 11363-2006 standard.

ISSUE NUMBER	
2 7 1 2 2 A D C	

12. 2±0. 05
10. 5□±0. 1 (*2)
Center of effective imaging area .

θ
CCD

11. 4±0. 05

5. 7±0. 075
0. 45±0. 45

Rotation error of die : θ=±1.5°
*1 : Effective imaging area
(*2 : Lid's size)

0. 85±0. 45
6. 1±0. 075

0. 6±0. 05 (*2)
Refractive index : nd=1.5
Glass Lid
CCD

5. 14MAX.
3. 37±0. 25
2. 75±0. 2
1. 3

1. 27±0. 25

3. 5±0. 3

1. 46±0. 025

0. 2
0. 1

0. 3TYP.

0. 64TYP.
0. 46TYP.

P-1. 27TYP.

⊕ 0. 25 Ⓜ

▭ 0. 03

∥ 0. 02
*1

0. 25±0. 05

11. 43±0.5

1   8

JAPAN
SHARP
RJ2331
BA0PB
YYWWXXX

Index Mark

16   9

(UNIT : mm)

材質 MATERIAL	仕上 FINISH	名称 NAME	WDIP16-P-450 Package Outline Specification
		コード CODE	
Assembly Process Technology Development Dept			
ELECTRONIC COMPONENTS AND DEVICES GROUP		図番 DRAWING No.	GDP016E-90E2
SHARP CORPORATION			

External Appearance of Packing